

Notice of References Cited	Application/Control No. 10/534,530	Applicant(s)/Patent Under Reexamination ENOKI ET AL.	
	Examiner Chuc D. Tran	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,611,224	08-2003	Nysen et al.	342/42
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*	E	US-6,239,656	05-2001	Nagata et al.	330/124R
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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